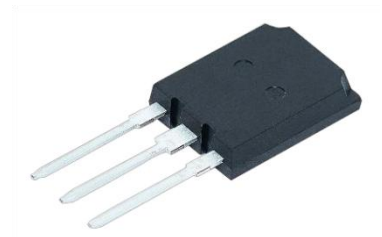
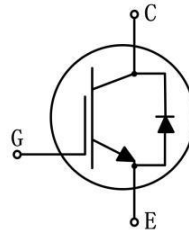


Trench Field-stop IGBT Discrete

Parameter	Value	Unit
V_{CE}	1200	V
I_C	75	A
$V_{CE(sat)}$	2.11	V



TO-247PLUS-3L

Features

- 1200V trench gate/field termination process
- Low switching losses
- V_{cesat} has a positive temperature coefficient

Applications

- Solar Inverter
- Welding Machine
- Uninterruptible power supplies

Maximum Ratings

Parameter	Symbol	Test condition	Value	Unit
Collector-Emitter voltage	V_{CE}	$T_{vj}=25^{\circ}C$	1200	V
Gate to Emitter Voltage	V_{GE}		± 20	V
Transient Gate to Emitter Voltage		$t_p \leq 0.5\mu s, D < 0.001$	± 30	V
collector current	I_C	$T_C=25^{\circ}C$ $T_C=100^{\circ}C$	150 75	A
Pulsed Collector Current	I_{pulse}	Pulse width limited by max junction temperature	300	A
Diode Forward Current	I_F	$T_C=25^{\circ}C$ $T_C=100^{\circ}C$	150 75	A
Power dissipation	P_{tot}	$T_C=25^{\circ}C$ $T_C=100^{\circ}C$	555 280	W
Operating Junction Temperature	T_J		-55 to +175	$^{\circ}C$
Storage Temperature Range	T_{stg}		-55 to +150	$^{\circ}C$
Thermal resistance junction - ambient	$R_{th(j-a)}$		40	$^{\circ}C/W$

Characteristic Values(IGBT)

Parameter	Symbol	Test condition	Value			Unit	
			Min.	Typ.	Max.		
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V, I_C=0.25mA$	1200			V	
Collector-Emitter saturation voltage	V_{CEsat}	$V_{GE}=15V, I_C=75A$ $V_{GE}=15V, I_C=75A$		$T_{vj}=25^{\circ}C$ $T_{vj}=175^{\circ}C$	2.11 3.03	2.60 V	
Gate-Emitter threshold voltage	$V_{GE(th)}$	$I_C=2.6mA, V_{GE}=V_{CE}$	$T_{vj}=25^{\circ}C$	5.0	5.6	6.5	V
Transconductance	G_{fs}	$V_{CE}=20V, I_C=75A$		98.8		S	

Gate charge	Q_G	$I_C=75A, V_{GE}=15V, V_{CE}=960V$ $T_{vj}=25^\circ C$	0.77		μC
Collector-emitter cut-off current	I_{CES}	$V_{CE}=1200V, V_{GE}=0V$ $T_{vj}=25^\circ C$		450	μA
Gate-emitter leakage current	I_{GES}	$V_{CE}=0V, V_{GE}=20V$ $T_{vj}=25^\circ C$		100	nA
Input capacitance	C_{ies}	$f=1MHz, V_{CE}=25V, V_{GE}=0V$ $T_{vj}=25^\circ C$	7.72		nF
Output capacitance	C_{oes}		0.28		
Reverse transfer capacitance	C_{res}		0.13		
Turn-on delay time	t_{don}	$I_C=75A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_G=10\Omega$ (inductive load) $T_{vj}=25^\circ C$	51		ns
Rise time	t_r		193		
Turn-off delay time	t_{doff}		180		
Fall time	t_f		98		mJ
Turn-on energy loss per pulse	E_{on}		9.5		
Turn-off energy loss per pulse	E_{off}		2.7		
Total switching energy	E_{tot}		12.2		
Turn-on delay time	t_{don}	$I_C=75A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_G=10\Omega$ (inductive load) $T_{vj}=175^\circ C$	40		mJ
Rise time	t_r		171		
Turn-off delay time	t_{doff}		202		
Fall time	t_f		119		
Turn-on energy loss per pulse	E_{on}		14.6		
Turn-off energy loss per pulse	E_{off}		3.5		
Total switching energy	E_{tot}		18.1		
IGBT thermal resistance, junction - case	$R_{th(j-c)}$		0.27		K/W

Characteristic Values(Diode)

Parameter	Symbol	Test condition	Value			Unit
			Min.	Typ.	Max.	
Forward voltage	V_F	$I_F=75A$ $T_{vj}=25^\circ C$ $I_F=75A$ $T_{vj}=175^\circ C$		1.93 1.67	2.40	V
Peak reverse recovery current	I_{RM}	$I_F=75A, -di_F/dt=320A/\mu s$ $V_R=600V, V_{GE}=-15V$ $T_{vj}=25^\circ C$		18		A
Reverse Recovered charge	Q_{rr}		4.21		μC	
Reverse Recovery Time	t_{rr}		444		ns	
Reverse recovered energy	E_{rec}		1.7		mJ	
Peak reverse recovery current	I_{RM}	$I_F=75A, -di_F/dt=320A/\mu s$ $V_R=600V, V_{GE}=-15V$ $T_{vj}=175^\circ C$		43		A
Reverse Recovered charge	Q_{rr}		15.36		μC	
Reverse Recovery Time	t_{rr}		767		ns	
Reverse recovered energy	E_{rec}		6.2		mJ	
Diode thermal resistance, junction - case	$R_{th(j-c)}$		0.28		K/W	

Typical Characteristics

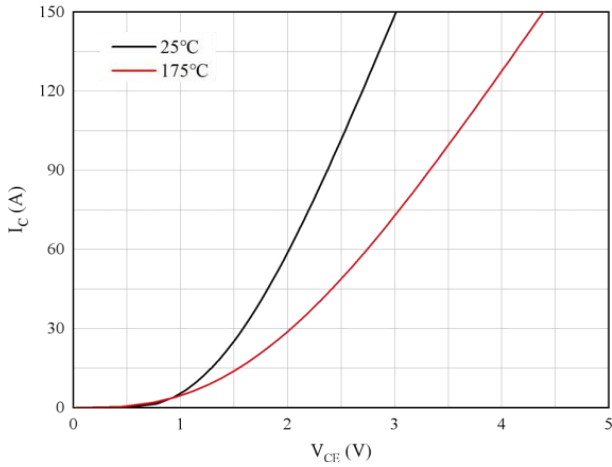


Fig 1. Typical output characteristics ($V_{GE}=15V$)

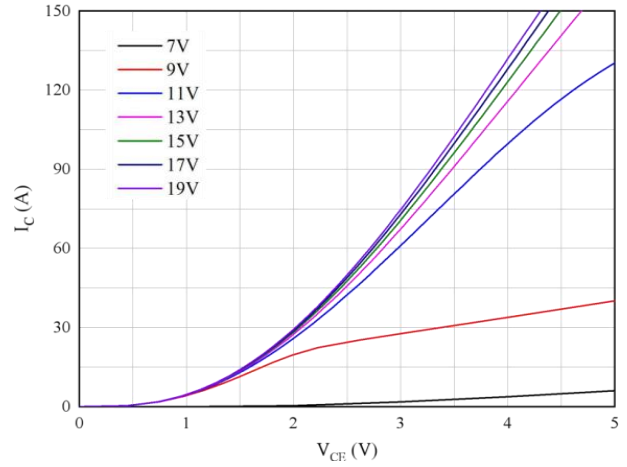


Fig 2. Typical output characteristics ($T_{vj}=175^\circ C$)

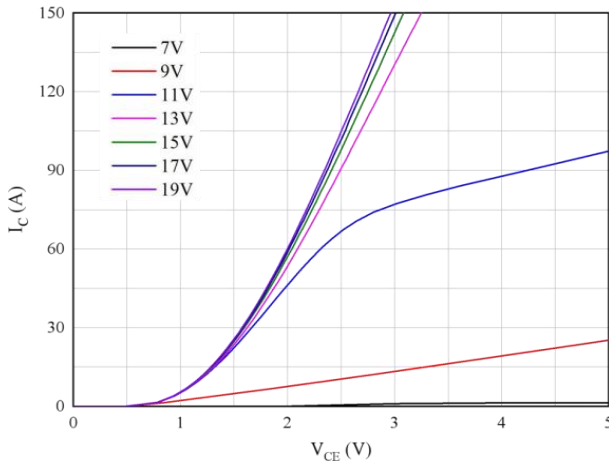


Fig 3. Typical output characteristics ($T_{vj}=25^\circ C$)

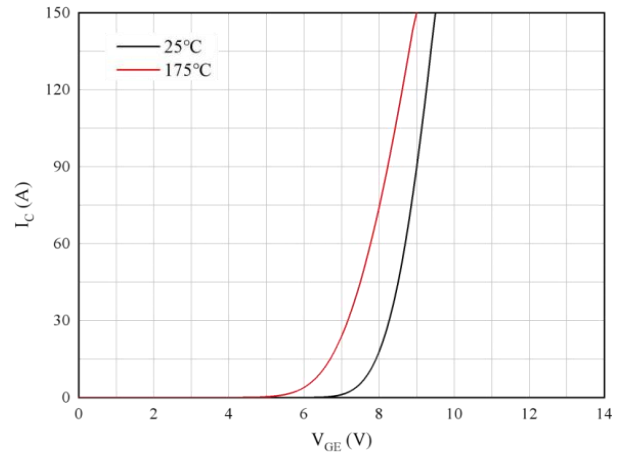


Fig 4. Typical transfer characteristic ($V_{CE}=20V$)

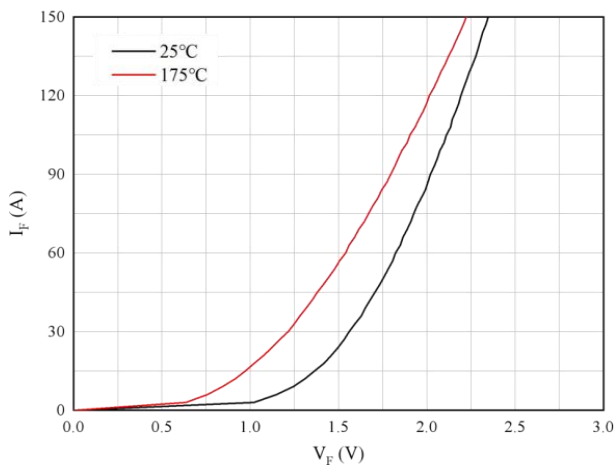


Fig 5. Forward characteristic of Diode

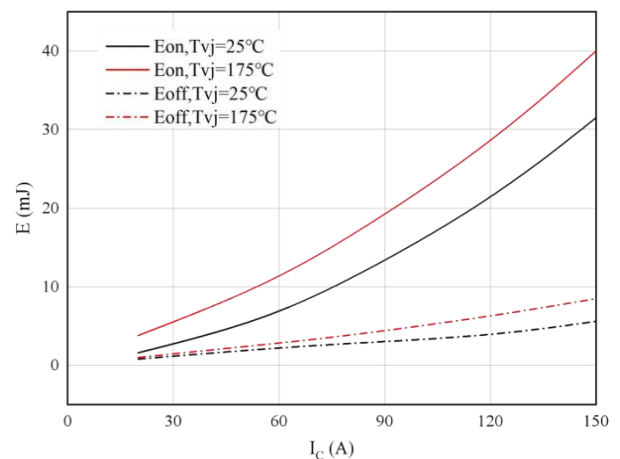


Fig 6. Switching losses of IGBT
 $V_{GE}=\pm 15V, R_{Gon}=10\Omega, R_{Goff}=10\Omega, V_{CE}=600V$

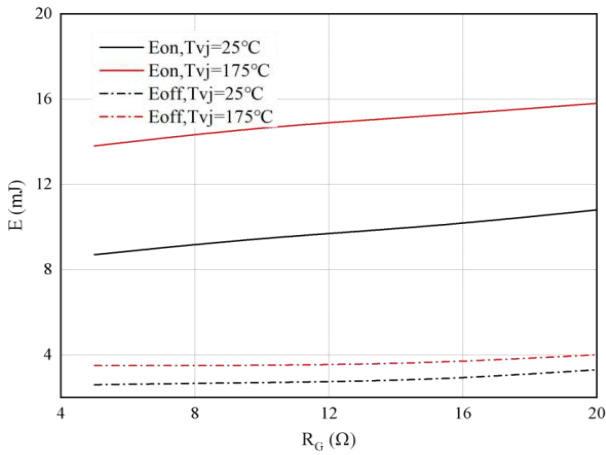


Fig 7. Switching losses of IGBT
 $V_{GE}=\pm 15V, I_C=75A, V_{CE}=600V$

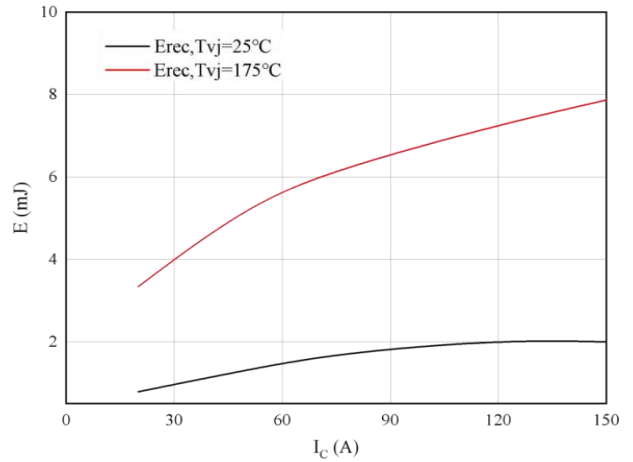


Fig 8. Switching losses of Diode
 $R_{gon}=10\Omega, V_{CE}=600V$

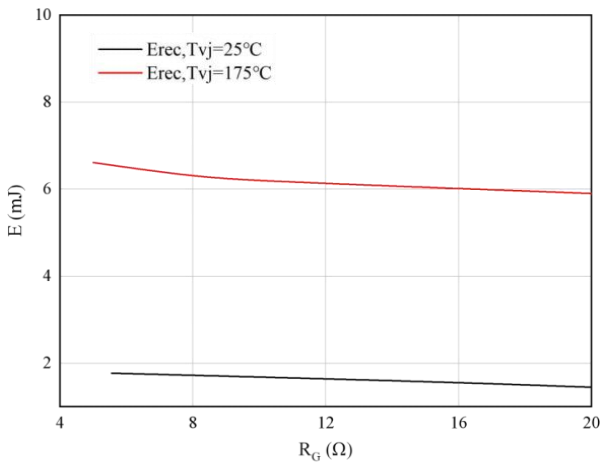


Fig 9. Switching losses of Diode
 $I_F=75A, V_{CE}=600V$

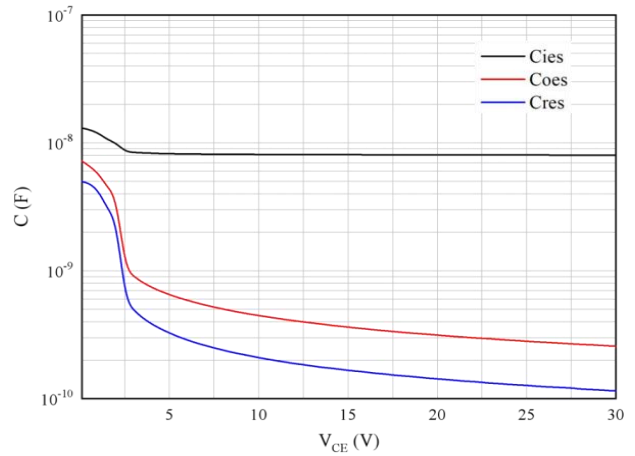


Fig 10. Capacitance characteristic

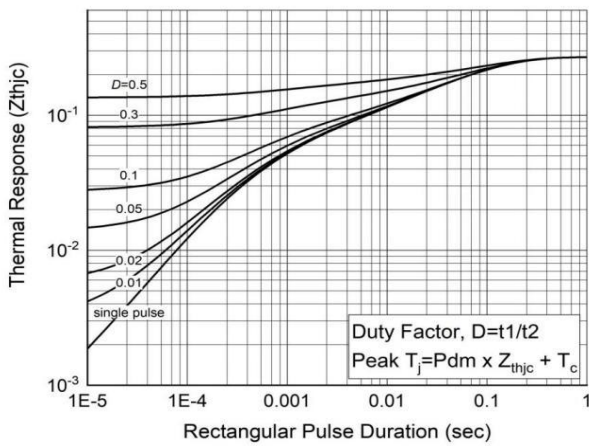


Fig 11. Transient thermal impedance IGBT,
 $Z_{thjc}=f(t)$

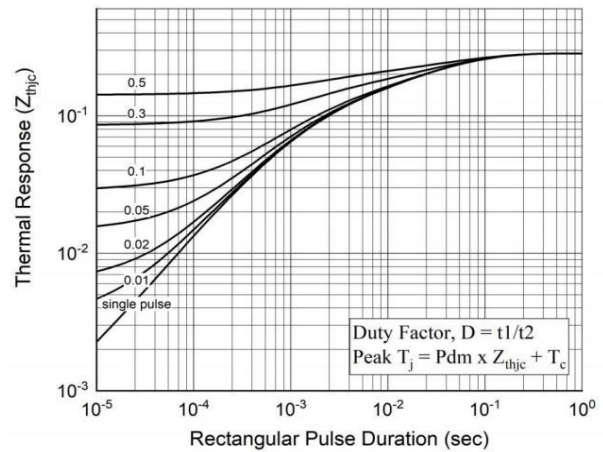
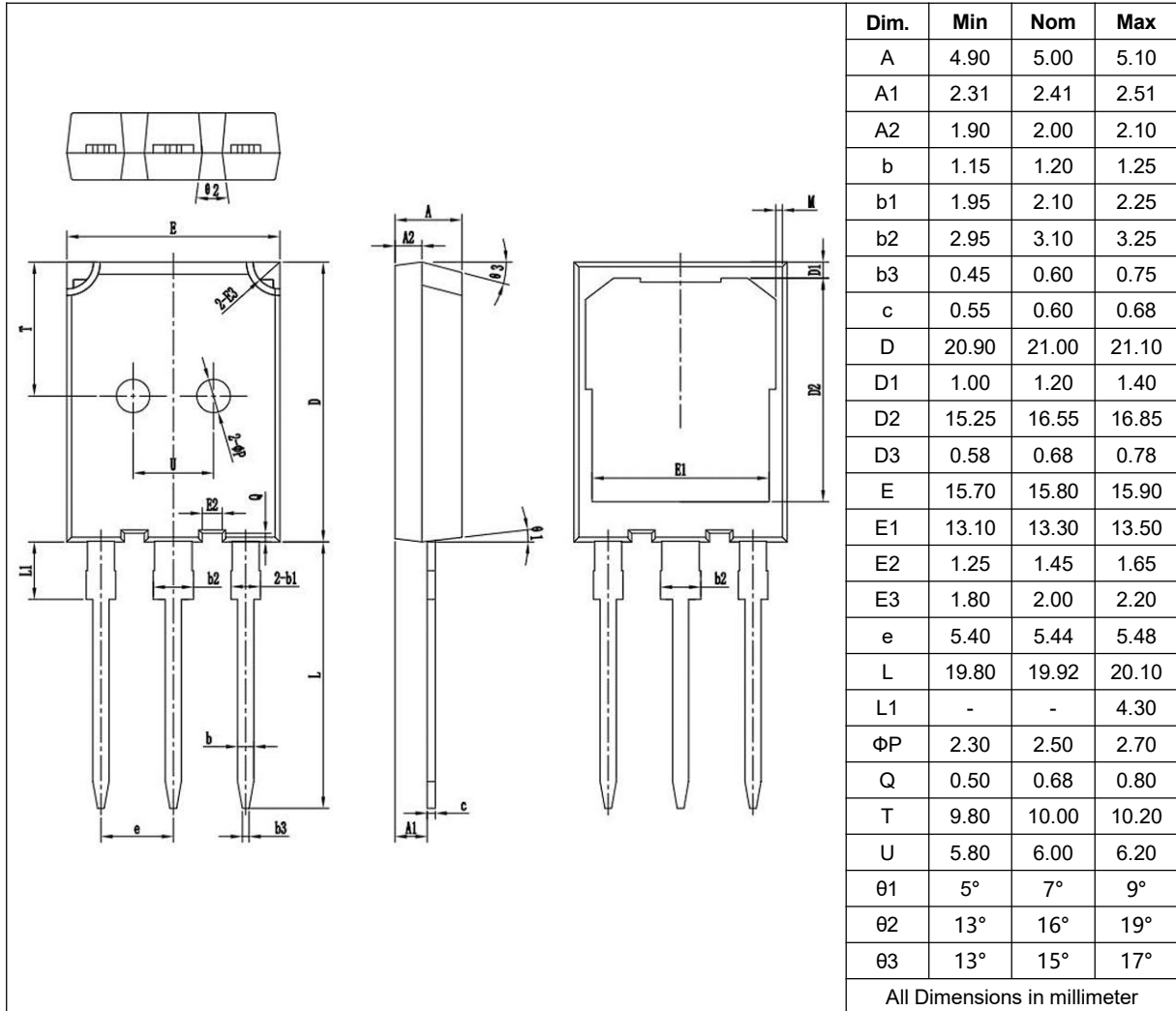


Fig 12. Transient thermal impedance FRD,
 $Z_{thjc}=f(t)$

Package Outline (Unit: mm)

TO-247PLUS-3L



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